

Description

The series of devices uses **Super Trench II** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

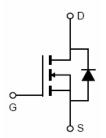
Application

- DC/DC Converter
- •Ideal for high-frequency switching and synchronous rectification

General Features

- V_{DS} =100V, I_D =62A $R_{DS(ON)}$ =4.4m Ω , typical @ V_{GS} =10V
- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 175 °C operating temperature
- Pb-free lead plating





Schematic Diagram

Package Marking and Ordering Information

	J	J			
Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST10N044-TF	VST10N044	TO-220F	-	-	-

Absolute Maximum Ratings (T_c=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	VDS	100	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous (Package Limited)	I _D	62	А	
Drain Current-Continuous(T _C =100°ℂ)	I _D (100℃)	45	A A W	
Pulsed Drain Current (Note 1)	I _{DM}	248		
Maximum Power Dissipation	P _D	40		
Derating factor		0.27	W/℃	
Avalanche Current ^(Note 1)	I _{AR}	55	Α	
Single pulse avalanche energy (Note 5)	E _{AS}	1156	mJ	
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	T _J ,T _{STG} -55 To 175		

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	R _{0JC}	3.75	°C/W



Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•		•	•
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100		_	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	I _{GSS}	V_{GS} =±20 V , V_{DS} =0 V	-	-	±100	nA
On Characteristics (Note 3)			•		•	•
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0	3.0	4.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =31A	-	4.4	4.8	mΩ
Forward Transconductance	G FS	V _{DS} =5V,I _D =31A		90	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	V -F0V/V -0V/	-	6400	-	PF
Output Capacitance	C _{oss}	$V_{DS}=50V, V_{GS}=0V,$	-	585	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	26	-	PF
Switching Characteristics (Note 4)			•	•		
Turn-on Delay Time	t _{d(on)}	V_{DD} =50V, I_{D} =31A V_{GS} =10V, R_{G} =1.6 Ω	-	20	-	nS
Turn-on Rise Time	t _r		-	11.5	-	nS
Turn-Off Delay Time	t _{d(off)}		-	48	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
Total Gate Charge	Qg	V _{DS} =50V,I _D =31A,	-	102	-	nC
Gate-Source Charge	Q _{gs}		-	36		nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	26		nC
Drain-Source Diode Characteristics			•	•		
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =31A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	62	Α
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C$, $I_F = I_S$	-	76	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	150	-	nC

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\!\!\mathrm{C}$,V_DD=50V,V_G=10V,L=0.5mH,Rg=25 Ω



Typical Electrical and Thermal Characteristics

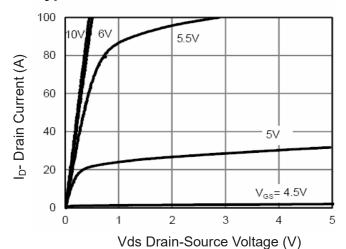


Figure 1 Output Characteristics

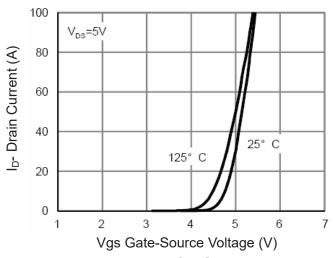


Figure 2 Transfer Characteristics

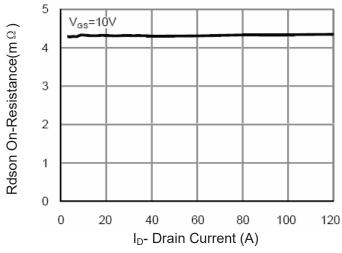


Figure 3 Rdson-Drain Current

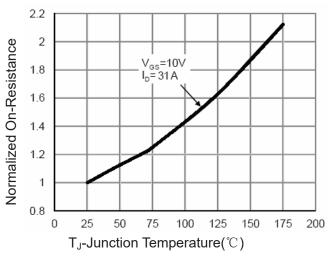


Figure 4 Rdson-Junction Temperature

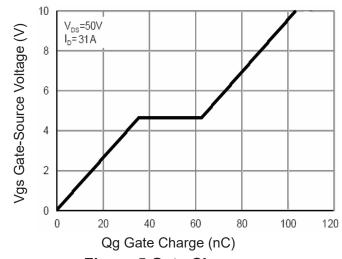


Figure 5 Gate Charge

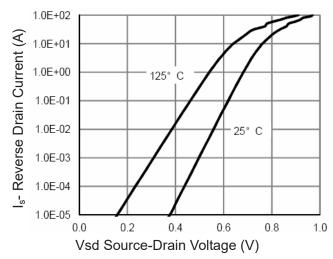


Figure 6 Source- Drain Diode Forward



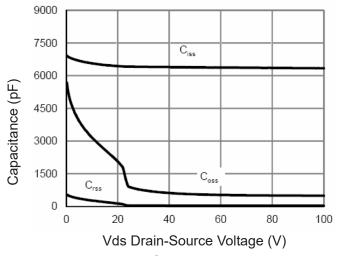


Figure 7 Capacitance vs Vds

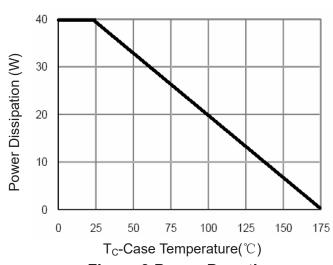


Figure 9 Power De-rating

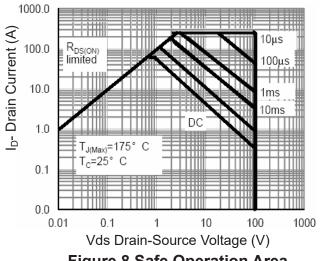


Figure 8 Safe Operation Area

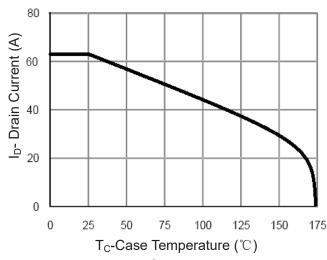
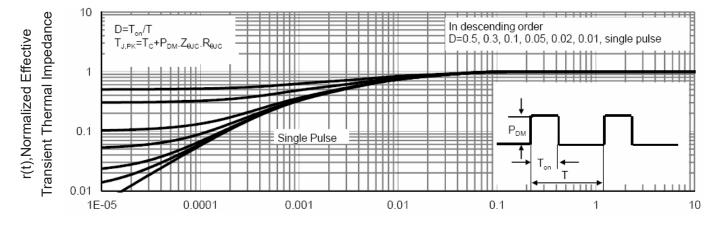


Figure 10 Current De-rating



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance